Notice of References Cited

1	Application/Control No.
	09/973,740
	Examiner
	Justin Knapp

Applicant(s)/Patent Under	
Reexamination	
CHEN ET AL.	
	_

Art Unit Page 1 of 1 2182

U.S. PATENT DOCUMENTS

		Date	U.S. PATENT DOCUMENTS	Classification
*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	
A	US-			
В	US-			
С	US-			
D	US-			
E	US-	ļ		
F	US-			
G	US-	ļ		
Н	US-	<u> </u>	,	
1	US-			
J	US-	<u> </u>		
К	US-			
L	US-			
N	US-		FOREIGN PATENT DOCUMENTS	1

				FOREIGN PATENT D	OCUMENTS	
		Document Number	Date	Country	Name	Classification
*		Country Code-Number-Kind Code	MM-YYYY	lanan	Battaglia, et al	G11B 33/02
	N	JP2000-132958	12-2000	Japan	Battaglia, et al	G11c 7/16
	0	EP1152428	11-2001	Europe	Battagila, ot ui	
7	P			<u> </u>		
_	Q			ļ		
	R		 	 		
	s		 			
	Т		<u> </u>	NON PATENT DO		

NON-PATENT DOCUMENTS

	NON-PATENT DOCUMENTS				
*	Γ -	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	www.camcor.com/cgi-bin/bcatalog.cgi/area=dig&id=1063315512			
-					
	V				
	w				
-	+-				
	×	forces in not being furnished with this Office action. (See MPEP § 707.05(a).)			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.